

Search Notes

Application/Control No.

10/659,568

Examiner

Amelia Rutledge

Applicant(s)/Patent under
Reexamination

CHEN ET AL.

Art Unit

2176

SEARCHED

Class	Subclass	Date	Examiner
715	512	2/15/2006	AR
715	512	8/2/2006	AR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST(US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB) -See Search History Printout; updated 8/2/06	2/15/2006	AR
ACM Digital Library search - see search printouts	2/15/2006	AR
IEEE Xplore database search	2/15/2006	AR